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Comparison of the Performance of the Memristor Models in 2D Cellular Nonlinear Network

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Abstract: Many charge controlled models of memristor have been proposed for various applications. First, the original linear dopant drift model suffers discontinuities close to the memristor layer boundaries. Then, the nonlinear dopant drift model improves the memristor behavior near these boundaries but lacks physical meaning and fails for some initial conditions. Finally, we present a new model to correct these defects. We compare these three models in specific situations: (1) when a sine input voltage is applied to the memristor, (2) when a constant voltage is applied to it, and (3) how a memristor transfers charges in a circuit point of view involving resistance-capacitance network. In the later case, we show that our model allows for study of the memristor behavior with phase portraits for any initial conditions and without boundary limitations.

Keywords: memristor; models; cellular nonlinear networks; charged cells; charge transfer; dynamics; analytical solution



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1. Introduction

Resistor, capacitor, and inductor are the three familiar basic passive circuit elements. The memory resistor (or memristor) was proclaimed to be the fourth basic passive circuit element which is defined by the constitutive relationship between magnetic flux ϕ and electric charge q [1]. Depending on the mode of excitation, memristor could be flux-controlled: $q = \hat{g}(\phi)$ or charge-controlled: $\phi = \hat{h}(q)$, where the functions \hat{g} and \hat{h} , respectively, characterize the memductance and memristance of the device. The first two-terminals solid state memristor was discovered in 2008, and the illustration of its well known signatures is given [2]. This discovery gave birth to widely reported memristor technologies and applications, having the potential to revolutionize electronic industries in neuroscience, nanotechnology, artificial intelligence, and so on [3,4].

Figure 1 shows the schematic of titanium-oxide (TiO₂) memristor [2], consisting of a bilayer of TiO₂, that is, doped-undoped layers. One of the layers is doped with oxygen vacancies, allowing for conduction, while the other layer is a pure TiO₂; thus, the setup exhibits two resistance limit states due to the expansion and the contraction of the doped layer. The mathematical description of TiO₂ memristor is originally expressed by the port and the state equations, respectively, as:

$$V(t) = \left(R_{off} - \delta R \frac{w}{D}\right) i(t), \tag{1}$$

$$\frac{dw}{dt} = \mu_v \frac{R_{on}}{D} i(t),\tag{2}$$

where *w* and *D* are geometric parameters denoting the widths of doped and total layers of TiO₂, respectively, μ_v is the dopant mobility, and R_{on} and R_{off} are the two resistance limits characterized by the doped and undoped regions, respectively, while $\delta R = R_{off} - R_{on}$

is the difference between R_{off} and R_{on} . Using the normalized width, that is, $x = \frac{w}{D}$ representing the normalized state variable of the device, Equations (1) and (2) become:

$$V(t) = \left(R_{off} - \delta Rx\right)i(t),\tag{3}$$

$$\frac{dx}{dt} = \frac{i(t)}{q_d},\tag{4}$$

where $q_d = \frac{D^2}{\mu_v R_{on}}$ is the charge scaling factor given by the technology parameters [5,6], thus representing the amount of charge required to move the boundary between the doped and the undoped regions from x = 0 to x = 1, and vice-versa.



Figure 1. Schematic of TiO₂ memristor.

Memristor becomes an important concept in Physics and electronics for design and control of quantum memristor devices [7,8] which exhibit superconducting characteristics based on Josephson junction with quasiparticle tunneling. Following the discovery of TiO₂ memristor, another sprouted field of interest is the memristor modeling in SPICE useful for circuit simulations [9–14]. This is particularly important due to the fact that memristor-based applications in SPICE or any other circuit simulator. Using off the shelf components, memristor is implemented experimentally [15,16], and a chaotic behavior with respect to the characteristic of its pinched hysteresis loop is investigated. However, the choice of a memristor model is very important [17]. In fact, some models are developed for specific applications such as logic design and chaotic circuits [18–20], while others are universal [21,22] useful for simulating many memristor-based applications. The comparison of some selected models of memristor is presented in Reference [23]. Each model has its own advantages, as well as disadvantages, thus suggesting some models to be better than the others.

Some intriguing features of memristor include memory capability for storage of information, nano-scalability suitable for the modern-day nano-technology, and connection flexibility because it can form series-parallel connections, thus being able to form stack of memory cells for high density storage applications, nonlinearity, low power consumption, and its ability to replace multiple transistors in a circuit; thus, it will ensure better performances and the most reliable systems.

These features, among many others, gave birth to a wide variety of reported memristorbased applications, proposed by adopting numerous models of memristor. Some of these applications include the implementation of chaotic circuits, field programmable gate array and programmable analogue logic circuits [24–27], high density memory applications, storage and processing of big data owing to memristor long retention and fast switching time [28–31] (e.g., Non-volatile random-access memory, Resistive random-access memory, etc.), cellular nonlinear or neural networks [32–34] useful for learning systems, neuromorphic systems, and bio-electronics (or bio-inspired) systems [35–39] because memristor offers fault tolerance and connection flexibility enabling massive parallel computation, edge detection, image recognition, and processing [40,41]. Furthermore, more interesting features of a memristor are the dynamics conductance resembling the chemical synapse and very effective high density connectivity [33,37], suggesting memristor to be reliable as electronic model of synapses. Recently, many implemented memristor-based synapses are reported by adopting various neumorphic computing architectures [42–47] showing good result in synaptic plasticity with memristors which is promising for achieving unsupervised learning in spiking neural networks.

Cellular nonlinear networks consist of elementary cells with each cell connected to its neighbors cells via coupling elements. Using memristor bridge circuit, a model of memristor-based cellular nonlinear network is analyzed, including study of its stability and fault tolerance [34]. The connection flexibility of a memristor and its compatibility with complementary metal oxide semiconductor neurons, is also essential for using memristor as synapse to achieve high connection density needed for massive computing [37,48]. Following this context, different hardware of memristor implementation is proposed [49]. The synchronization phenomena of memristor coupling two neuron cells is also investigated theoretically and numerically [50–52].

We introduce the application of memristor in two-dimensional cellular nonlinear or neural networks using memristors in the coupling mode, essentially for signal processing and electronic prosthesis. Memristors are used in place of the series resistances of the conventional network [53]. To explore the quantitative and qualitative behavior of memristor in the network, this text focuses on the system of two cells coupled together by a memristor. Then, follow by the details interaction of the memristor within the cells with respect to the charge q(t) flowing from one cell to the other one. In recent studies [54,55], the system was described analytically but here emphasize on its circuit point of view giving the dynamics and the steady state response. The circuit responses are compared using three different models of memristor, including a new one which happens to be suitable in the study of our system dynamics owing to its continuity for any flowing charge through the memristor.

2. Memristor Modeling

Depending on the nature of the ionic transport, the description of TiO₂ memristor is completed in 2 ways, namely: linear and nonlinear dopant drift models. The difference between these models stands in the dynamics of the boundary between the doped and undoped TiO₂ material toward the extreme edges, that is, x = 0 and x = 1, corresponding to the dopant width w = 0 and w = D.

Equation (4) characterizes the linear dopant drift model and is integrated to give:

$$x(t) = x_0 + \frac{1}{q_d}(q(t) - q_0),$$
(5)

where x_0 represents the limit between the doped and the undoped regions at time t = 0, and q_0 is the initial charge at the same time t = 0, that is, the charge having already flowed through the memristor in its previous history. Here, it can be seen that, from the first use of the memristor, as no charge has already flowed through it, $q_0 = 0$ corresponds to $x_0 = 0$, giving $x(t) = \frac{q(t)}{q_d}$. Be aware that it is only true for x belonging to [0, 1], that is, for q(t) in $[0, q_d]$. This first model leads then to transform Equation (3) by $V(t) = M(q) \cdot i(t)$, with

 $M(q) = R_{off} - \delta R \frac{q(t)}{q_d}$ as a charge-controlled memristance. However, this definition must be completed when q(t) is less than 0 or more than q_d , leading to:

$$M(q) = \begin{cases} R_{off}, & \text{if } q \leq 0\\ R_{off} - \delta R \frac{q}{q_d}, & \text{if } 0 < q < q_d.\\ R_{on}. & \text{if } q \geq q_d \end{cases}$$
(6)

In the nonlinear model, a dimensionless function g(x), called window function, is introduced to the right-hand side of the state Equation (4) to ensure the operating region in the interval [0, 1]; thus:

$$\frac{dx}{dt} = g(x)\frac{i(t)}{q_d}.$$
(7)

There are many suggested window functions, but their choice has a significant effect in the memristor modeling [17]. Considering three different window functions proposed, respectively, by Strukov et al., Joglekar et al., and Prodromakis et al. [2,5,56], each can be used for nonlinear dopant drift modeling:

$$g(x) = x(1-x),$$
 (8)

$$g(x) = 1 - (2x - 1)^{2p},$$
(9)

and

$$g(x) = 1 - [(x - 0.5)^2 + 0.75]^p,$$
⁽¹⁰⁾

where *p* is a positive integer acting as a control parameter. Figure 2 shows the comparison of the functions in Equations (8)–(10). Note that, for p = 1, Equation (9) becomes 4x(1 - x), i.e., Joglekar's function is four times the Strukov's function given by Equation (8), while, for p = 1, Prodromakis's function in Equation (10) is exactly the same as Strukov's function in Equation (8). The basic noticeable difference between these functions is the $g_{max} = g(x = 0.5)$ scaleability, where g_{max} is the value of g(x) when x = 0.5. There is no control parameter *p* in Strukov's function; hence, it always gives $g_{max} = 0.2500$, whereas Joglekar's function always gives $g_{max} = 1$. However, for Prodromakis's function, g_{max} varies with the variations of *p*; for example, Figure 2 gives $g_{max} = 0.2500$, 0.9437, and 0.9968 for p = 1, 10, and 20, respectively.



Figure 2. Comparison of the three window functions by Strukov et al., Joglekar et al., and Prodromakis et al. When p = 1, Prodromakis's function gives the same than Strukov's, but, when p increases, g_{max} in Prodromakis's increases until $g_{max} = g(x = 0.5) = 1$.

From the circuit point of view and using a sine input voltage source: $V(t) = V_0 sin(2\pi ft)$, where V_0 is the voltage amplitude, and f is the input frequency. Figure 3 shows the comparison of the three window functions for the same initial conditions and input source.

The SPICE model of memristor [9] is used for the circuit simulation. The abbreviations P, J and S correspond, respectively, to Prodromakis, Joglekar, and Strukov. The control parameter p = 1 is used for Joglekar's function, while p = 20 is used for Prodromakis window function so that g(x = 0.5) = 1 is the same for both functions, except the one by Strukov. Thus, it allows for easy comparison. Figure 3a1–a4,b1–b4,c1–c4 are for input voltage 1 V, 1.2 V, and 1.5 V, respectively, showing that the dynamics of the memristance and the state variable increases differently as the input voltage increases. The current i_P , i_J , and i_S are, respectively, according to Prodromakis, Joglekar, and Strukov models. Figure 3c1–c4 shows the hard switching case, that is, when the memristor is subjected to a substantial amount of input voltage. It is clear that the choice of a window function for a memristor modeling is very important because each function responds dynamically different.



Figure 3. Comparing the effect of a window function from the circuit point of view: Strukov (S), Jolekar (J), and Prodromakis (P). V(t) is a sine input voltage with frequency f = 1 Hz and different amplitudes, i(t) is the current, and x and M(x) are the state variable and the memristance, respectively. The results are obtained for three cases of voltage amplitude as: (**a1–a4**) $V_o = 1$ V, (**b1–b4**) $V_o = 1.2$ V, and (**c1–c4**) $V_o = 1.5$ V.

3. Linear and Nonlinear Models Comparison

Figure 4 shows the comparison of linear and nonlinear models on the memristance transition with respect to the flowing charge. For the linear drift model, the memristance transits linearly, whereas, in the nonlinear drift model, it transits nonlinearly and in a cubic fashion. For unity control parameter, that is, p = 1, the nonlinearity is more pronounced; however, with the increase in p, the nonlinear model approaches the linear model.



Figure 4. Memristance versus charge for linear and nonlinear drift models (Joglekar). It shows that as *p* increases, the nonlinear drift model tends to the linear model. Window function gives nonlinear model. Window function, in addition to nonlinearity, also increases the dynamics of the charge (or mobile carrier thereby affected by the value of q_d , because $q_d \propto \frac{1}{\mu_v} = \hat{f}(\mu_v)$). Therefore, for a fixed device dimension (i.e., *D*) and doping, only μ_v is affected by the window function; hence, q_d . This is due to the fact that window function ensures zero drift of the mobile carrier at the boundaries, thus significantly reducing their mobility and increasing q_d .

Figure 5 compares the responses of the linear and the nonlinear models using Joglekar's window function and for the same values of parameters. The comparison aims to observe the dynamics of state variable x, the corresponding memristance, and the current-voltage graph, by using a periodic input voltage source for three different values of the input voltage amplitudes 0.7 V, 1 V, and 1.2 V, shown, respectively, by Figure 5a1–a4,b1–b4,c1–c4.

It is observed that, for a small input voltage, for example, 0.7 V, given by Figure 5a1–a4, the behaviors of the linear and nonlinear models are virtually the same, as can be seen from the corresponding *I-V* characteristics (Figure 5a2). This is due to the fact that the boundary between the doped and the undoped regions operates not close to the layer limit 0 or *D*, which means that a small voltage causes a small displacement of the state variable *x* and, hence, a small transition of the memristance. Except for a very small shift in Figure 5a3,a4 where the memristance (M₁) and state variable (x₁) in the case of the linear model tend to transit faster than the one by the nonlinear model (M_{nl}) and (x_{nl}), both models respond in the same way when the input voltage is small.

Figure 5b1–b4 show the case where the input voltage is increased to 1 V; hence, the state variable displaces farther and the difference between linear and nonlinear models begins to be noticeable. Figure 5c1–c4 show the case when the input voltage is increased to 1.2 V; in fact, the difference between the linear and nonlinear models becomes apparent. Figure 5c1 shows a shift difference in the current transients for linear (i₁) and nonlinear (i_{n1}) models when the voltage is high and it becomes apparent in the corresponding Figure 5c2. Figure 5c3,c4 show that the memristance transition and the displacement of the state variable (M₁ and x₁, respectively) in the case of the linear model are higher than the ones for the nonlinear model (M_{n1} and x_{n1}, respectively) when the input voltage is high.



Figure 5. Comparison of the linear and nonlinear dopant drift models showing for each case, the nature of the flowing currents, the *I-V* characteristics, the memristance, and the corresponding state variable transition, respectively, where V(t) is a sine input voltage with different amplitudes and f = 1 Hz, and i_l and i_{nl} are the flowing currents for linear and nonlinear drift model, respectively; similarly, x_l , M_l , x_{nl} , and M_{nl} are the state variables and the memristances for the linear and nonlinear models, respectively. (a1–a4) $V_o = 0.7$ V, (b1–b4) $V_o = 1$ V, and (c1–c4) $V_o = 1.2$ V.

For the same initial conditions, Figure 6 shows the nonlinear models comparison of the memristance transition from its highest resistance state ($R_{off} = 16 \text{ K}\Omega$) to the lowest one ($R_{on} = 100 \Omega$), and vice-versa, with respect to the flowing charge q(t). It shows that the amount of charge q_R required for each model to fully transit from R_{off} to R_{on} , and vice-versa, depends on the model under consideration. Hence, this is very important in deciding which model to use for any application. For Joglekar's function and for p = 1, $q_R = 350 \ \mu\text{C}$. For Prodromakis's function, $q_R = 150 \ \mu\text{C}$, but, here, p = 20, so that g_{max} can scale up to 1 for both models, except for Strukov's one because it has no p. This allows for accurate comparison of the results. For Strukov's function, $q_R = 1.3$ mC, and the detailed comparison of these models is illustrated in Table 1. It is to be noted that the amount of charge q_R required to fully drive memristor from R_{off} to R_{on} , and vice-versa, depends strongly on the initial memristance and the value of p (in cases of Joglekar and Prodromakis functions). Furthermore, Figure 7 shows the corresponding transient results of the memristance M(q) and the flowing charge q(t) for each model. When the flowing charge increases, the memristance transits toward R_{on} , and, when the charge decreases, the memristance transits toward R_{off} .



Figure 6. Nonlinear models comparison of the full memristance transition between $R_{off} = 16 \text{ K}\Omega$ and $R_{on} = 100 \Omega$ with respect to the quantity of the flowing charge q(t). It shows the amount of charge q_R needed for each model to fully transit from R_{off} to R_{on} . Note that p = 1 and p = 20 for Joglekar and Prodromakis, respectively, allowing to have $g_{max} = 1$ for both models. (a) Prodromakis, (b) Joglekar, and (c) Strukov.



Figure 7. The corresponding transient results of Figure 6, memristance M(q) and the charge q(t) for Prodromakis (P), Joglekar (J), and Strukov (S).

Table 1. Comparison of the three nonlinear dopant drift models.

Window Function $g(x)$	Strukov	Joglekar	Prodromakis	
Resolve boundary issues	✓	1	1	
Impose nonlinear drift	\checkmark	\checkmark	1	
Linkage with linear drift	×	\checkmark	1	
Control parameter	×	\checkmark	1	
g_{max} scalability	×	×	1	
q_R value	1.3 mC	350 µC	150 μC	

Knowing that $q = \int_{-\infty}^{t} i(\tau) d\tau = \int_{0}^{t} i(\tau) d\tau + q_{0}$, with q_{0} the initial charge already flowed through the memristor and x_{0} the initial boundary between doped and undoped regions, from Equation (7), the state variable is a function of the flowing charge, such that $q \in [0, q_{d}]$. From the port Equation (3) and considering the function by Strukov et al. in Equation (8): $\int_{x_{0}}^{x} \frac{dx^{*}}{x^{*}(1-x^{*})} = \frac{q-q_{0}}{q_{d}}$; thus:

$$x(t) = \frac{x_0 e^{\frac{q-q_0}{q_d}}}{1 - x_0 + x_0 e^{\frac{q-q_0}{q_d}}},$$
(11)

and the expression of the memristance is expressed as:

$$M(q) = R_{off} - \delta R \; \frac{x_0 \, e^{\frac{q-q_0}{q_d}}}{1 - x_0 + x_0 \, e^{\frac{q-q_0}{q_d}}}.$$
(12)

There are two problems related to this model. First, there is no physical reason to add g(x) in the right-side member of Equation (7), only a mathematical reason to avoid x(t) to go outside of [0, 1]. Secondly, x_0 is present and cannot be put to be equal to 0, as x = 0 is not possible in Equation (12), also due to mathematical integration of dx/(x(1-x)), because the lower boundary cannot be set to 0. This problem means that we cannot use this model for the first use of the memristor, when it is virgin, without any charge already flowed in the memristor. For a small value of p, similar calculation can be obtained using Joglekar function. But when p is large, then the equation can only be solved numerically.

Given the memristor relationships (3) and (4): $\frac{dx}{dt} = \frac{i(t)}{q_d}$ and $M(x) = R_{off} - \delta Rx$,

then $i(t) = \frac{V(t)}{M(x)}$, where V(t) is the input voltage applied to the memristor. Therefore, using a constant input voltage *V* and the linear model, the relationship can be expressed as:

$$\int_{x_0}^x \left(R_{off} - \delta R \; x^* \right) dx^* = \frac{1}{q_d} \int_0^t V dt^*.$$
(13)

When *x* reaches 1, $t = t_1$, which is obtained from (13) as:

$$t_1 = \frac{q_d}{V} \left[R_{off} - \frac{\delta R}{2} - R_{off} x_0 + \frac{\delta R}{2} x_0^2 \right].$$

Solving Equation (13) and keeping only the relevant physical solution, we get, respectively, the normalized boundary between the doped and the undoped regions x(t) and the memristance M(t) versus time:

$$x(t) = \frac{R_{off} - \sqrt{(R_{off} - \delta R x_0)^2 - \frac{2\delta R \cdot V}{q_d}t}}{\delta R} \text{ for } t \in [0, t_1], \text{ and } x(t) = 1 \text{ for } t \ge t_1,$$

and

λ

$$M(t) = \sqrt{(R_{off} - \delta R x_0)^2 - \frac{2\delta R \cdot V}{q_d}t}, \text{ for } t \in [0, t_1], \text{ and } M(t) = R_{on} \text{ for } t \ge t_1.$$

Now, using the nonlinear model with, for example, Strukov's window function, that is, Equation (8) with g(x) = x(1 - x) instead of Equation (4), we get:

$$R_{off}\ln\left(\frac{x}{x_0}\right) - R_{on}\ln\left(\frac{1-x}{1-x_0}\right) = \frac{V \cdot t}{q_d},\tag{14}$$

that is, the same mathematical limitations when $x_0 = 0$ or 1, and when x(t) becomes close to the boundaries 0 or 1. Therefore, the nonlinear model seems to be not adapted, even in the simplest case of a constant voltage excitation through the memristor.

The solid curve in Figure 8 shows the memristance evolution with respect to the flowed charge according to Equation (6), and it has discontinuities at q = 0 and $q = q_d$, as can be seen clearly by the formed angulation. This causes a hinderance on the study of our system dynamics presented in Section 4. We propose then a new memristor model allowing to perform the analytical study of the system dynamics [55]:

$$M(q) = \begin{cases} R_{off}, & \text{if } q \leq 0\\ R_{off} - \frac{3 \,\delta R}{q_d^2} \,q^2 + \frac{2 \,\delta R}{q_d^3} \,q^3, & \text{if } 0 \leq q \leq q_d \,.\\ R_{on}, & \text{if } q \geq q_d \end{cases}$$
(15)



Figure 8. Memristance as a function of the flowed charge for the models by Equations (6) and (15). $R_{on} = 1 \text{ K}\Omega$, $R_{off} = 16 \text{ K}\Omega$, and $q_d = 100 \text{ }\mu\text{C}$. The proposed model is continuous for all charges, and it is suitable in the study of our system dynamics.

Similarly, the memristance transition according to (15) is shown by the dashed curve in Figure 8, and it solves the problem of discontinuities at q(t) = 0 and $q(t) = q_d$. Furthermore, Figure 9 shows the circuit response of the new model. Recall that $d\phi = M(q)dq$, which can be integrated for any given initial conditions (ϕ_0 and q_0), where ϕ is the magnetic flux. Using the sine input voltage source and varying the voltage amplitude in three steps, the results show the ϕ -q curve, the *I*-*V* characteristics, the memristance, and the state variable transients. The ϕ -q curve of a memristor is always a monotically increasing function showing the graphical response of its magnetic flux ϕ versus charge q, and vice-versa. Considering the input voltage as 0.75 V, 1 V, and 1.2 V, shown, respectively, by Figure 9a1–a3,b1–b2,c1–c3. Figure 9c2 shows the hard switching case, i.e., the scenario occuring when a substantial amount of input voltage is applied to the memristor [2].



Figure 9. Circuit response of the proposed model (15). Values of parameters used: $R_{on} = 100 \Omega$, $R_{off} = 16 \text{ K}\Omega$, $q_d = 100 \mu\text{C}$, and sine input voltage for three amplitudes and same frequency f = 1 Hz. It shows for each case, the ϕ -q curve, the *I*-*V* characteristic, the memristance, and state variable transition, respectively. (a1–a3) $V_o = 0.75 \text{ V}$, (b1–b3) $V_o = 1.0 \text{ V}$, and (c1–c3) $V_o = 1.2 \text{ V}$.

Now, with our proposed model (15), the mathematical problem met with Equation (14) is easily solved as we simply have:

$$V \cdot t = \int_{q_0}^q M(q^*) dq^*,$$

which is always integrable to give the total charge q(t) flowed at time t through the memristor when a constant voltage V is applied across its ports during a time t.

4. System Description

Figure 10a shows the schematic of the proposed memristor-based 2D cellular nonlinear network, using memristors in the coupling mode. The network is to be used for signal processing and biomedical applications, for example, electronic prosthesis, due to the reliable conductance modulation of memristor, which resembles chemical synapse. Each cell constitutes one nonlinear linear resistor R_{NL} in parallel with one linear capacitor. The resistance-capacitance RC network characterizes the passive electrical properties of neurons. Figure 10b shows the system of two charged RC cells, namely: Cell-1 and Cell-2 coupled together by a memristor. This allows for study, both quantitatively and qualitatively, of the interaction of the memristor within the cells. Cell-1, whose elements are marked with the subscript number 1, acts as the source of information to Cell-2, labeled with subscript 2, through the memristor. The direction of the flowing current i(t) indicates the direction of the flowing charge from Cell-1 to Cell-2 via memristor, until the system is saturated.

First, Figure 11 compares the responses of the system using the nonlinear models by Strukov, Joglekar, and Prodromakis, respectively. It shows that the dynamics and the steady response of the system depend on the model under consideration. For the same initial conditions, Figure 11a shows the time evolution of the charge flowing through the memristor according to the models by Strukov, Joglekar, and Prodromakis. Meanwhile, Figure 11b shows the corresponding memristance transition. The results are obtained for $V_{1_0} = 2 V$, $V_{2_0} = 0 V$, $R_1 = R_2 = 100 \text{ K}\Omega$, $C_1 = C_2 = 1 \mu\text{F}$, $q_0 = 19 \mu\text{C}$, and $q_d = 100 \mu\text{C}$. V_{1_0} and V_{2_0} are the initial conditions of Cell-1 and Cell-2, respectively. The results show different transitions of the memristance. The system stabilizes at a time where $V_1(t) = V_2(t)$ and the current flowing through the memristor is zero. Thus, the flowing charge and the corresponding memristance remain constant, as can be seen by the flattening of the curves. Using the new model, a similar procedure is followed, and the result is shown in Figure 12. Table 2 shows the values of the main parameters. The initial conditions V_{1_0} , V_{2_0} , and q_0 are our adjustable parameters. It is from Table 2 that every other subsequent parameter are calculated.



Figure 10. Proposed memristor-based network. (**a**) Two-dimensional cellular nonlinear network using memristive coupling. (**b**) System of two charged RC cells coupled by a memristor.

Table 2. Values of parameters used.

Parameter	R _{off}	Ron	q_d	R_{1}, R_{2}	C_1, C_2	V_{1_0}	$V_{2_{0}}$	q_0
Value	16 KΩ	100 Ω	100 µC	100 KΩ	1 μF	2 V	0 V	30 µC



Figure 11. Memristor models comparison in the response of the two cells system, Strukov (S), Joglekar (J), and Prodromakis (P). It clearly shows that each model differs from one another in the system dynamics and the steady state response. $V_{1_0} = 2 \text{ V}$, $V_{2_0} = 0 \text{ V}$, $R_1 = R_2 = 100 \text{ K}\Omega$, $C_1 = C_2 = 1 \mu\text{F}$, $R_{off} = 16 \text{ K}\Omega$, $R_{on} = 100 \Omega$, and $q_d = 100 \mu\text{C}$. (a) Flowing charge q(t) through the memristor, from master to the slave; (b) the memristance M(q) transition.



Figure 12. Response of the two cells system using the new model of the memristor showing the flowing charge and the corresponding memristance transition. $V_{1_0} = 2 \text{ V}$, $V_{2_0} = 0 \text{ V}$, $R_1 = R_2 = 100 \text{ K}\Omega$, $C_1 = C_2 = 1 \mu\text{F}$, $R_{off} = 16 \text{ K}\Omega$, $R_{on} = 100 \Omega$, and $q_d = 100 \mu\text{C}$.

Secondly, the charge flowing from Cell-1 to Cell-2 through the memristor can be observed analytically. The following gives the analytical description of the system. Closing at time t = 0 the switches s_1 and s_2 , Kirchhoff's laws give the following system of equations:

$$i(t) = -C_1 \frac{dV_1(t)}{dt} - \frac{V_1(t)}{R_1},$$
(16)

$$i(t) = C_2 \frac{dV_2(t)}{dt} + \frac{V_2(t)}{R_2},$$
(17)

$$V_1(t) - V_2(t) = M(q) \frac{dq}{dt}$$
, (18)

and $i(t) = \frac{dq}{dt}$. By simple algebraic rearrangement of Equations (16)–(18) and considering Cell-1 and Cell-2 been identical such that the time contstant $\Gamma = R_1C_1 = R_2C_2$, then, from Equation (16) and Equations (17), respectively:

$$R_1 i(t) = -\Gamma \frac{dV_1}{dt} - V_1 \text{ and } R_2 i(t) = \Gamma \frac{dV_2}{dt} + V_2.$$

Adding these two equations and using $V_1(t) - V_2(t) = M(q) \frac{dq}{dt}$ from (18), it becomes:

$$\frac{dV_1}{dt} - \frac{dV_2}{dt} = -\frac{R_a}{\Gamma}\frac{dq}{dt} - \frac{1}{\Gamma}\left(M(q)\frac{dq}{dt}\right),\tag{19}$$

where $R_a = R_1 + R_2$.

Equation (19) can be solved in 2 ways. First, the equation can be integrated directly and then solved simultaneously with (18) in order to find explicit expressions of $V_1(t)$ and $V_2(t)$ as functions of the charge q(t) flowing through the memristor. Secondly, the equation can be reformulated and then substituted in (18) directly, which allows study of the dynamics of the charge q(t) evolution in the phase plane.

Considering the first method of solving Equation (19), that is, integrating (19), thus:

$$V_1 - V_2 = (V_{1_0} - V_{2_0}) - \frac{R_a}{\Gamma}(q - q_0) - \frac{\eth}{\Gamma},$$
(20)

where:

$$\eth = \int_{q_0}^{q} M(q^*) \, dq^*.$$
 (21)

As $V_1 - V_2 = M(q) \frac{dq}{dt}$ given by Equation (18), and substituting M(q) with $\left(R_{off} - \delta R \frac{q}{q_d}\right)$ from Equation (6), and then Equation (20) becomes:

$$\left(R_{off} - \delta R \frac{q}{q_d}\right) \frac{dq}{dt} = \left(V_{1_0} - V_{2_0}\right) - \frac{R_a}{\Gamma}(q - q_0) - \frac{\eth}{\Gamma}.$$
(22)

Furthermore, using the expression of M(q) in Equation (6), the expression of \eth is obtained from Equation (21) as:

$$\eth = R_{off} (q - q_0) - \frac{\delta R}{2 q_d} (q^2 - q_0^2),$$

and Equation (22) becomes:

$$\frac{2\Gamma q_d}{\delta R} \left(R_{off} - \delta R \frac{q}{q_d} \right) \frac{dq}{dt} = (q^2 - q_0^2) - \frac{2q_d R_b}{\delta R} \left(q - q_0 \right) + \frac{2\Gamma q_d}{\delta R} \left(V_{1_0} - V_{2_0} \right), \tag{23}$$

where $R_b = R_a + R_{off}$. Let $q' = q - q_0$, then dq' = dq and $q^2 = (q' + q_0)^2 \Rightarrow q^2 - q_0^2 = q'^2 + 2q_0 q'$. Using the the new variable q', then Equation (23) becomes:

$$\frac{2\Gamma q_d}{\delta R} \left(M(q_0) - \frac{\delta R}{q_d} q' \right) \frac{dq'}{dt} = q'^2 - 2 \left[\frac{q_d R_b}{\delta R} - q_0 \right] q' + \frac{2\Gamma q_d}{\delta R} \left(V_{1_0} - V_{2_0} \right),$$
$$= (q' - \alpha)(q' - \beta),$$
$$= P(q'), \tag{24}$$

where $M(q_0) = \left(R_{off} - \delta R \frac{q_0}{q_d}\right)$, P(qt) is a second degree polynomial, and α and β are the roots of P(qt) given by the characteristic equation:

$$q\prime^2 - 2\left[\frac{q_d R_b}{\delta R} - q_0\right]q\prime + \frac{2\Gamma q_d}{\delta R}\left(V_{1_0} - V_{2_0}\right) = 0$$

Rewriting Equation (24) in terms of $P(q\prime)$ as:

$$\left(M(q_0) - \frac{\delta R}{q_d}q'\right)\frac{dq'}{P(q')} = \frac{\delta R}{2\Gamma q_d}dt \Rightarrow \left[\frac{\kappa_1}{q'-\alpha} + \frac{\kappa_2}{q'-\beta}\right]dq' = \frac{\delta R}{2\Gamma q_d}dt,$$
(25)

 κ_1 and κ_2 are constants due to the partial fraction decomposition and are determined, respectively, as:

$$\kappa_1 = \frac{1}{(\alpha - \beta)} \left(M(q_0) - \frac{\delta R}{q_d} \alpha \right)$$

$$\kappa_2 = -\frac{1}{\alpha - \beta} \left(M(q_0) - \frac{\delta R}{q_d} \beta \right).$$

and

$$\kappa_1 \ln\left(\frac{\alpha + q_0 - q}{\alpha}\right) + \kappa_2 \ln\left(\frac{\beta + q_0 - q}{\beta}\right) = \frac{\delta R t}{2\Gamma q_d} , \qquad (26)$$

or equivalently expressed as:

$$\left[\frac{\alpha+q_0-q}{\alpha}\right]^{\kappa_1} \left[\frac{\beta+q_0-q}{\beta}\right]^{\kappa_2} = e^{\frac{\delta R t}{2\Gamma q_d}} .$$
(27)

For example, Figure 13 shows the system evolution according to the outlined analytical solution. The considered values of parameters are $R_{off} = 16 \text{ K}\Omega$, $R_{on} = 100 \Omega$, $q_d = 100 \mu\text{C}$, $R_1 = R_2 = 100 \text{ K}\Omega$, $C_1 = C_2 = 1 \mu\text{F}$, and $\Gamma = R_1C_1 = 0.1 \text{ s}$. R_a and R_b are calculated accordingly. Using an initial charge $q_0 = 30 \mu\text{C}$ with $V_{10} = 1 \text{ V}$, $V_{20} = 0 \text{ V}$, and α and β are calculated from the characteristic Equation (24). Knowing α and β , κ_1 and κ_2 can be easily determined. Recall that the cells are considered to be identical with $\Gamma = R_1C_1 = R_2C_2$, substituting (17) into (16); thus:

$$V_2 = \frac{\lambda}{C_2} e^{-\frac{t}{\Gamma}} - \frac{C_1}{C_2} V_1 , \qquad (28)$$

where $\lambda = C_1 V_{1_0} + C_2 V_{2_0}$ is a constant fixed by the initial conditions. Equations (20) and (28) are solved simultaneously to give the expressions of $V_1(t)$ and $V_2(t)$ in terms of the flowing charge through the memristor:

$$V_1(t) = \frac{\lambda}{C_a} e^{-\frac{t}{\Gamma}} + \frac{C_2}{C_a} (V_{1_0} - V_{2_0}) - \frac{C_2 R_a}{\Gamma C_a} (q - q_0) - \frac{C_2}{\Gamma C_a} \vec{o},$$
(29)

$$V_2(t) = \frac{\lambda}{C_a} e^{-\frac{t}{\Gamma}} - \frac{C_1}{C_a} (V_{1_0} - V_{2_0}) + \frac{C_1 R_a}{\Gamma C_a} (q - q_0) + \frac{C_1}{\Gamma C_a} \eth,$$
(30)

where $C_a = C_1 + C_2$. Figure 13a shows that the charge flowing from Cell-1 to Cell-2 through the memristor increases until $V_1(t) = V_2(t)$, and that is when the voltage across the memristor is zero, i.e., $V_1(t) - V_2(t) = 0$. At this time, the flowing current is zero, and the combined evolution of $V_1(t)$ and $V_2(t)$ stabilizes to zero. When $V_1(t) = V_2(t)$, Cell-1 and Cell-2 are stabilized. This scenario is to be further explored in phase portraits analysis as follows.



Figure 13. Illustration of the analytical solution showing the time evolution of (**a**) charge q(t), (**b**) voltage $V_1(t)$ and $V_2(t)$. $R_1 = R_2 = 100 \text{ K}\Omega$, $C_1 = C_2 = 1 \text{ }\mu\text{F}$, $V_{1_0} = 1 \text{ V}$ and $V_{2_0} = 0 \text{ V}$, $R_{off} = 16 \text{ K}\Omega$, $R_{on} = 100 \Omega$, $q_0 = 30 \mu\text{C}$, and $q_d = 100 \mu\text{C}$.

The second method of solving Equation (19) entails studying the system in the phase plane allowing us to visualize the evolution of the charge for different initial conditions of the system. Equation (19) is reformulated as:

$$\frac{d}{dt} (V_1(t) - V_2(t)) = -\frac{R_a}{\Gamma} \frac{dq}{dt} - \frac{1}{\Gamma} \left(M(q) \frac{dq}{dt} \right)$$

Then, substituting $V_1(t) - V_2(t) = M(q) \frac{dq}{dt}$ from Equation (18), we get:

$$\left(R_a + M(q)\right) \frac{dq}{dt} + \Gamma \frac{d}{dt} \left[M(q) \frac{dq}{dt}\right] = 0 \; \Rightarrow$$

$$\left(R_a + M(q)\right)\frac{dq}{dt} + \Gamma \frac{dM(q)}{dq}\left(\frac{dq}{dt}\right)^2 + \Gamma M(q) \frac{d^2q}{dt^2} = 0.$$
(31)

Equation (31) is a second order nonlinear differential equation characterizing the dynamics of the charge q(t) flowing from Cell-1 to Cell-2 through memristor. Indeed, Equation (31) is similar to the one in Reference [54] where one approach for its phase plane analysis is presented in Reference [55], including the case where $q(t) \le 0$ and $q(t) \ge q_d$. However, in the following and depending on the initial conditions, we highlight some others possible analytical interpretations. One thing that requires attention though, is the expression of M(q) given by Equation (6), whose first derivative with respect to charge must be continuous according to (31). However, Equation (6) does not clearly respect this requirement as can be seen by the angular manifestation of the solid curve at q(t) = 0 and $q(t) = q_d$; see Figure 8. The proposed new model of M(q) respects this continuity requirement as shown by the dashes curve in Figure 8. One intriguing thing of the new model is that it is continuous and requires no window function.

Using the normalized form: $X = \frac{q}{q_d}$ as the normalized charge and $\tau = \frac{t}{\tau_c}$ as the normalized time, then with $Y = \frac{dX}{d\tau}$ as the normalized current and $\mathcal{M}(X) = \frac{M(X)}{\delta R}$ as the normalized memristance, the equivalent normalized form of Equation (31) becomes:

$$\left(\frac{R_a}{\delta R} + \mathscr{M}(X)\right)Y + \frac{d\mathscr{M}(X)}{dX}Y^2 + \mathscr{M}(X)\frac{dY}{d\tau} = 0,$$
(32)

with

$$\mathscr{M}(X) = \frac{R_{off}}{\delta R} - 3 X^2 + 2 X^3.$$
(33)

Therefore, we rewrite Equation (32) as:

$$\begin{cases} \frac{dY}{d\tau} = -\frac{(X^3 - \frac{3}{2}X^2 + \gamma_1)Y + 3(X^2 - X)Y^2}{X^3 - \frac{3}{2}X^2 + \gamma_2},\\ \frac{dX}{d\tau} = Y, \end{cases}$$
(34)

which is simplified to give:

$$H(X,Y) = \left(X^3 - \frac{3}{2}X^2 + \gamma_2\right)Y + \frac{1}{4}X^4 - \frac{1}{2}X^3 + \gamma_1 X = h,$$
(35)

where: $\gamma_1 = \frac{R_b}{2\delta R}$, $\gamma_2 = \frac{R_{off}}{2\delta R}$, and H(X, Y) is a conservative quantity similar to the Hamiltonian in mechanics depending on initial conditions. Taking into account these initial conditions of the system q_0 , V_{1_0} , V_{2_0} , and $X_0 = \frac{q_0}{q_d}$, then $Y_0 = Y(X_0)$ is obtained from (18) and (33), as:

$$Y_0 = \frac{\Gamma(V_{1_0} - V_{2_0})}{q_d \delta R \mathscr{M}(X_0)}.$$
(36)

With $Y = \frac{dX}{d\tau}$, Equation (35) becomes:

$$\frac{X^{3} - \frac{3}{2}X^{2} + \gamma_{2}}{X^{4} - 2X^{3} + 4\gamma_{1}X - 4h} dX = -\frac{d\tau}{4} \Rightarrow$$

$$\tau = \tau_{o} - 4 \int_{X_{0}}^{X} \frac{P_{3}(X^{*})}{P_{4}(X^{*})} dX^{*},$$
 (37)

where: $P_3(X) = X^3 - \frac{3}{2}X^2 + \gamma_2$ and $P_4(X) = X^4 - 2X^3 + 4\gamma_1X - 4h$ are third and fourth degree polynomials in terms of *X*, and τ_0 is the time corresponding to the initial state *X*₀.

In addition to the study of the phase portraits for the system (34), it is important to look for the existence of real roots of $P_4(X)$ and singularity points of the system. The equilibrium points of the system are met when $\frac{dY}{d\tau} = 0$ and $\frac{dX}{d\tau} = Y = 0$, corresponding to $V_1(t) = V_2(t)$, i.e., the voltage across the memristor becomes $V_1(t) - V_2(t) = 0$. The equilibrium points of the system (34), in focusing on Equation (37), are directly deduced as Y = 0 is enough to have $\frac{dX}{d\tau} = 0$ and $\frac{dY}{d\tau} = 0$. Then, every point (X, Y = 0) is possibly an equilibrium point. Similarly, the singularity points of the system (34) are where the derivative $\frac{dY}{dX}$ is undefined, which is obtained directly from (34) as:

$$X^3 - \frac{3}{2}X^2 + \gamma_2 = 0. ag{38}$$

Equation (37) is to be solved analytically depending on the given values for γ_1 , γ_2 , and h. Therefore, for $h \in [-\infty, +\infty]$ and depending on two particular values of h, namely h_e and $h_s > h_e$, the four possible analytical solutions of (37) are outlined in Appendix A.

For example, Figure 14 shows the phase portraits using Equation (A4). The trajectories are obtained for different initial conditions, and the arrows show the direction of the flowing charge from one cell to the other one through the memristor. Note that, for $X \leq 0$ (and ≥ 1), $M(X) = R_{off}$ (and R_{on}), respectively. The considered values of the parameters are $R_{off} = 16 \text{ K}\Omega$, $R_{on} = 100 \Omega$, $q_d = 100 \mu$ C, $C_1 = C_2 = 1 \mu$ F, and $R_1 = R_2 = 100 \text{ K}\Omega$, which gives $\gamma_1 = 6.792$, $\gamma_2 = 0.503$, and $\Gamma = 0.1$ s. The initial memristance is given by the parameter q_0 or the equivalent normalized form X_0 . For any given initial memristance $M(X_0)$, V_{1_0} and V_{2_0} , Y_0 is obtained from Equation (36), and the value of h is determined according to the expression of M(X). Furthermore, the coefficients in Equation (A4) are obtained accordingly. Note that Figure 10b is a bidirectional communication between Cell-1 and Cell-2 via memristor. $V_{1_0} = 1$ V and $V_{2_0} = 0$ V implies that Cell-1 is the master and it is shown by the trajectories with rightward arrows, while $V_{1_0} = 0$ V and $V_{2_0} = 1$ V implies Cell-2 is the master, and is shown by the leftward arrows. The direction of the current i(t)flowing through the memristor depends on which cell is acting as the master as determined by the initial conditions of the system. Similarly, all the arrows are pointing to the steady state giving by the line Y = 0, corresponding to the time evolution when $V_1(t) = V_2(t)$.



Figure 14. Phase portraits showing the charge evolution under different initial conditions of X_0 .

5. Discussion

Memristor modeling is an important aspect of memristor-based networks. Both linear and nonlinear models are widely used to simulate memristor-based applications. The characteristics of the three commonly used nonlinear dopant drift models are analyzed and tabulated. From the circuit point of view, the linear and the nonlinear models respond indifferently when the input voltage is very small; however, their responses differ greatly as the applied input increases. We showed that the amount of charge required to fully transit memristance from its high resistance state to the lower one, and vice-versa, differs for each model, because each function offers different dynamics in maintaining its state variable to operate within the desired interval. The comparison results take into account the different transitions of the state variable, the memristance and the current-voltage characteristics. Hence, the choice of a window function is paramount in the memristor modeling as each window function accounts for different system behavior. It is also important to note that the differences in these models have practical implication, for example, in the synaptic weight when using memristor as synaptic function, which can greatly influence the plasticity and its learning, because the conductance responds differently according to the quantity of the flowing charge for each model. Secondly, different chaotic behaviors can be observed owing to the different imposed nonlinear dynamics.

Memristor-based 2D nonlinear networks is introduced, for signal processing and electronic prosthesis. The setup is analyzed by considering a system of two cells which enables us to study the quantitative and qualitative behavior of memristor in the network. We compared the nature of the charge transfer from one cell to the other one using the outlined models of memristor. The results are obtained under the same initial conditions. For each model, we observed different transitions of the charge and the corresponding memristance. The dynamics and the steady state response of the system are affected by the memristor model under consideration.

Using 2 RC cells coupled by memristor, the evolution of the voltage $V_1(t)$ and $V_2(t)$ for Cell-1 and Cell-2, respectively, is obtained analytically as a function of the flowing charge q through the memristor. $V_1(t)$ and $V_2(t)$ evolve separately until $V_1(t) = V_2(t)$, that is, when the cells are saturated, hence the voltage across the memristor being zero, that is, $V_1(t) - V_2(t) = 0$, and the flowing charge is constant. Due to the resistive nature of the cells, the combined evolution of $V_1(t)$ and $V_2(t)$ eventually decays to zero. We described the system dynamics characterizing the charge transfer between the two RC-cells through a memristor. The equation is solved analytically using the new model due to its desirable continuity. Depending on the value of h, four possible solutions of Equation (37) are presented in Appendix A. The system evolution is observed in the phase plane for any initial condition. The phase portraits show the evolution trajectories from one cell to the other one via memristor under different initial conditions. The arrows pointing from left to right is when Cell-1 is the master, whereas the arrows pointing from right to left is when Cell-2 is the master. The lack of symmetry emphasizes the asymmetry nature of a memristor. Note that, when Cell-2 becomes the master, some of the signs (i.e., + and -) in the system of Equations (16)–(18) change, and it affects the subsequent derivation. But the whole process is the same.

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Abbreviations

The following abbreviations are used in this manuscript:

- MDPI Multidisciplinary Digital Publishing Institute
- DOAJ Directory of open access journals
- CNN Cellular Nonlinear Network

Appendix A. Outlined Solutions of (37)

1. *for* $h \in [-\infty, h_e]$: $P_4(X)$ has no real root. The solution of (37) becomes:

$$d\tau = (-4) \frac{X^3 - \frac{3}{2}X^2 + \gamma_2}{(X^2 + \beta_1 X + \beta_2)(X^2 + \beta_3 X + \beta_4)} dX,$$

where:

$$\beta_1 = 1 - \sqrt{1 + 2\sigma}; \ \beta_3 = 1 + \sqrt{1 + 2\sigma},$$

 $\beta_2 = \sigma - \frac{2\gamma_1 + \sigma}{\sqrt{1 + 2\sigma}}; \ \beta_4 = \sigma + \frac{2\gamma_1 + \sigma}{\sqrt{1 + 2\sigma}},$

.

with:

$$-\sigma^{3} + (2\gamma_{1} - 4h)\sigma + 2(\gamma_{1}^{2} - h) = 0,$$

$$\tau = \tau_{o} - 4 \int_{X_{0}}^{X} \left(\frac{b_{0} + b_{1}X}{X^{2} + \beta_{1}X + \beta_{2}} + \frac{b_{2} + b_{3}X}{X^{2} + \beta_{3}X + \beta_{4}}\right) dX_{0}$$

where

$$b_{0} = \frac{\frac{5}{2}\beta_{2} + \gamma_{2}}{\beta_{4} - \beta_{2}}; \ b_{2} = \frac{\gamma_{2} + \frac{5}{2}\beta_{4}}{\beta_{2} - \beta_{4}},$$

$$b_{1} = \frac{\beta_{2}(\beta_{2} - \beta_{4}) + \frac{5}{2}(\beta_{1}\beta_{4} - \beta_{2}\beta_{3}) + \gamma_{2}(\beta_{1} - \beta_{3})}{(\beta_{4} - \beta_{2})^{2}},$$

$$b_{3} = \frac{\beta_{4}(\beta_{4} - \beta_{2}) + \frac{5}{2}(\beta_{2}\beta_{3} - \beta_{1}\beta_{4}) + \gamma_{2}(\beta_{2} - \beta_{1})}{(\beta_{4} - \beta_{2})^{2}},$$

and then:

$$\tau = \tau_o - 4 \left[\ln \left[(X^2 + \beta_1 X + \beta_2)^{\frac{b_1}{2}} (X^2 + \beta_3 X + \beta_4)^{\frac{b_3}{2}} \right] + \frac{2b_0 + b_1 \beta_1}{\sqrt{4\beta_2 - \beta_1^2}} \arctan \left(\frac{2}{\sqrt{4\beta_2 - \beta_1^2}} \left[X + \frac{\beta_1}{2} \right] \right) + \frac{2b_2 + b_3 \beta_3}{\sqrt{4\beta_4 - \beta_3^2}} \arctan \left(\frac{2}{\sqrt{4\beta_4 - \beta_3^2}} \left[X + \frac{\beta_3}{2} \right] \right) \right].$$
(A1)

for $h = h_e$: $P_4(X)$ has a double real root called X_e , and Equation (37) is solved as follows: 2.

$$d\tau = (-4) \left[\frac{e_0}{X - X_e} + \frac{e_1}{(X - X_e)^2} + \frac{e_3 X + e_4}{X^2 + \tilde{a}_1 X + \tilde{a}_2} \right] dX_e$$

 $X_e^3 - \frac{3}{2}X_e^2 + \gamma_2$

where:

$$e_{1} = \frac{1}{X_{e}^{2} + \tilde{a}_{1}X_{e} + \tilde{a}_{2}},$$

$$e_{3} = \frac{\left(\tilde{a}_{1} + 2X_{e}\right)\left[\gamma_{2} + \tilde{a}_{2}\left(\frac{3}{2} + \tilde{a}_{1}\right)\right] - \left[\tilde{a}_{2} - \tilde{a}_{1}\left(\frac{3}{2} + \tilde{a}_{1}\right)\right]\left(X_{e}^{2} - \tilde{a}_{2}\right)}{\left(\tilde{a}_{1} + 2X_{e}\right)\left(2\tilde{a}_{2}X_{e} + \tilde{a}_{1}\tilde{a}_{2}\right) + \left(X_{e}^{2} - \tilde{a}_{2}\right)\left(2X_{e}\tilde{a}_{1} - \tilde{a}_{2} + \tilde{a}_{1}^{2} + X_{e}^{2}\right)},$$

$$e_{4} = \frac{\left(2X_{e}\tilde{a}_{1} - \tilde{a}_{2} + \tilde{a}_{1}^{2} + X_{e}^{2}\right)\left[\gamma_{2} + \tilde{a}_{2}\left(\frac{3}{2} + \tilde{a}_{1}\right)\right] - \left(2\tilde{a}_{2}X_{e} + \tilde{a}_{1}\tilde{a}_{2}\right)\left[\tilde{a}_{1}\left(\frac{3}{2} + \tilde{a}_{1}\right) - \tilde{a}_{2}\right]}{\left(\tilde{a}_{1} + 2X_{e}\right)\left(2\tilde{a}_{2}X_{e} + \tilde{a}_{1}\tilde{a}_{2}\right) + \left(X_{e}^{2} - \tilde{a}_{2}\right)\left(2X_{e}\tilde{a}_{1} - \tilde{a}_{2} + \tilde{a}_{1}^{2} + X_{e}^{2}\right)},$$

and

$$e_0 = \alpha_3 - e_3, \ \tilde{a}_1 = -\frac{4h_e}{X_e^2} \ \text{and} \ \tilde{a}_2 = 2X_e - 2.$$

$$\tau = \tau_o - 4 \left[e_0 \ln \left(X - X_e \right) - \frac{e_1}{X - X_e} + \frac{2e_4 - \tilde{a}_1 e_3}{\sqrt{4\tilde{a}_2 - \tilde{a}_1^2}} \arctan \left(\frac{2}{\sqrt{4\tilde{a}_2 - \tilde{a}_1^2}} \left[X + \frac{\tilde{a}_1}{2} \right] \right) \right].$$
(A2)

3. *for* $h = h_s$: $P_3(X)$ and $P_4(X)$ have a same real root. Equation (37) becomes:

$$-\frac{d\tau}{4} = \frac{P_{2S}(X)}{P_{3S}(X)}dX$$

and $P_{3S}(X)$ has another real root called X_{s_a} . We get:

$$\mathrm{d}\tau = (-4) \bigg[\frac{e_9}{X - X_{s_a}} + \frac{e_{10}X + e_{11}}{X^2 + \lambda_2 X + \lambda_8} \bigg] \mathrm{d}X,$$

where:

$$X_{s_a} < X_e < X_s < 0; \quad H(X_{s_a}, Y_{s_a}) = h_s \quad \Rightarrow$$

$$\tau = \tau_o - 4 \left[e_9 \ln \left(X - X_{s_a} \right) + \frac{2e_{11} - \lambda_2 e_{10}}{\sqrt{4\lambda_8 - \lambda_2^2}} \arctan \left(\frac{2}{\sqrt{4\lambda_8 - \lambda_2^2}} \left[X + \frac{\lambda_2}{2} \right] \right) \right]. \quad (A3)$$

4. *for* $h \in]h_e, h_s[\cup]h_s, +\infty[: P_4(X)$ has 2 distinct real roots, X_{a_1} and X_{a_2} , while the 2 others are complex ones. Then, Equation (37) becomes:

$$d\tau = (-4) \left[\frac{e_{18}}{X - X_{a_1}} + \frac{e_{19}}{X - X_{a_2}} + \frac{e_{20} + e_{21}X}{X^2 + \lambda_1 X + \lambda_2} \right] dX_A$$

with $X_{a_1} < X_e < X_{a_2}$,

$$e_{18} = \frac{X_{a_1}^3 - \frac{3}{2}X_{a_1}^2 + \gamma_2}{(X_{a_1} - X_{a_2})(X_{a_1}^2 + \lambda_1 X_{a_1} + \lambda_2)}; \quad e_{19} = \frac{X_{a_2}^3 - \frac{3}{2}X_{a_2}^2 + \gamma_2}{(X_{a_2} - X_{a_1})(X_{a_2}^2 + \lambda_1 X_{a_2} + \lambda_2)},$$
$$e_{20} = e_{11}(X_{a_1} + X_{a_2} - \frac{3}{2} - e_{19}(\lambda_1 - X_{a_1}) - e_{18}(\lambda_1 - X_{a_2}))$$

.•.

$$\tau = \tau_o - 4 \ln \left[\left(X - X_{a_1} \right)^{e_{18}} \left(X - X_{a_2} \right)^{e_{19}} \left(X^2 + \lambda_1 X + \lambda_2 \right)^{\frac{e_{11}}{2}} \right] + (-4) \frac{2e_{20} - \lambda_1 e_{21}}{\sqrt{4\lambda_2 - \lambda_1^2}} \arctan \left[\frac{2}{\sqrt{4\lambda_2 - \lambda_1^2}} \left(X + \frac{\lambda_1}{2} \right) \right].$$
(A4)

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